

FCC CFR47 PART 20.19 ANSI C63.19-2007

HAC RF EMISSIONS TEST REPORT

For

Cellular/PCS/AWS CDMA and LTE Phone with Bluetooth and WLAN

MODEL: MS840, LGMS840 and LG-MS840 FCC ID: ZNFMS840

REPORT NUMBER: 11U13993-11 ISSUE DATE: October 7, 2011

Prepared for

LG ELECTRONICS MOBILECOMM U.S.A., INC. 10101 OLD GROVE ROAD SAN DIEGO, CA 92131

Prepared by

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NVLAP LAB CODE 200065-0

Revision History

Rev.	Issue Date	Revisions	Revised By
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1. Attestation of Test Results

Applicant name:	LG ELECTRONICS MOBILECOMM U.S.A., INC.					
EUT description:	Cellular/PCS/AWS CDMA and LTE Band 2/4 Phone with Bluetooth and WLAN					
Model name:	MS840, LGMS840 and LG-MS840 IMEI: 99000073000108					
Device category:	Portable					
Exposure category:	General Population/Uncontrolled Exposure					
Date of tested:	August 29, 2011					
Maximum E/H-Filed Emiss	ions					
Max. E-Field emissions:	Part 22 - Cellular band: 54.262 V/m (M4) Part 27 - AWS band: 27.675 V/m (M4) Part 24 - PCS band: 33.834 V/m (M4)					
Max. H-Field emissions:	Part 22 - Cellular band:	0.079 A/m (N	,			
	Part 27 - AWS band: 0.077 A/m (M4)					
	Part 24 - PCS band: 0.089 A/m (M4)					
Hearing Aid Near-Field Ca	tegory: M4					
Appli	Applicable Standards Test Results					

ANSI C63.19-2007 Pass
Compliance Certification Services, Inc. (UL CCS) tested the above equipment in accordance with the
requirements set forth in the above standards. All indications of Pass/Fail in this report are opinions
expressed by LIL CCS based on interpretations and/or observations of test results. Measurement

expressed by UL CCS based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Note: The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL CCS and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL CCS will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, any agency of the Federal Government, or any agency of any government (NIST Handbook 150, Annex A). This report is written to support regulatory compliance of the applicable standards stated above.

Approved & Released For UL CCS By:

Sernay Shih

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Tested By:

an

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2. Test Methodology

The tests documented in this report were performed in accordance with ANSI C63.19-2007 Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids and FCC KDB 285076 D01 HAC Guidance v02r01

3. Facilities and Accreditation

The test sites and measurement facilities used to collect data are located at 47173 Benicia Street, Fremont, California, USA.

UL CCS is accredited by NVLAP, Laboratory Code 200065-0. The full scope of accreditation can be viewed at <u>http://www.ccsemc.com.</u>

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4. Calibration and Uncertainty

4.1. Measuring Instrument Calibration

The measuring equipment utilized to perform the tests documented in this report has been calibrated in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

<u>Manufacturer</u>	Type/Model	Serial Number	<u>Cal. Due date</u>
Stäubli	TX90 XL	N/A	N/A
SPEAG	SEUMS001BA	1041	N/A
SPEAG	DAE4	1257	5/3/12
SPEAG	ER3DV6	2509	4/8/12
SPEAG	H3DV6	6324	4/11/12
SPEAG	CD835V3	1175	5/3/12
SPEAG	CD1880V3	1159	5/3/12
Giga-Tronics	8651A	8651404	5/13/12
Giga-Tronics	80701A	1834588	5/13/12
Mini-Circuits	ZHL-42W	D072701-5	N/A
Agilent	8960	GB46160222	6/17/12
HP	8665B	3744A01084	N/A
	Stäubli SPEAG SPEAG SPEAG SPEAG SPEAG Giga-Tronics Giga-Tronics Mini-Circuits Agilent	StäubliTX90 XLSPEAGSEUMS001BASPEAGDAE4SPEAGER3DV6SPEAGH3DV6SPEAGCD835V3SPEAGCD1880V3Giga-Tronics8651AGiga-Tronics80701AMini-CircuitsZHL-42WAgilent8960	StäubliTX90 XLN/ASPEAGSEUMS001BA1041SPEAGDAE41257SPEAGER3DV62509SPEAGH3DV66324SPEAGCD835V31175SPEAGCD1880V31159Giga-Tronics8651A8651404Giga-TronicsZHL-42WD072701-5Agilent8960GB46160222

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4.2. Measurement Uncertainty

HAC Uncertainty Budget According to ANSI PC63.19

Error Description	Uncertainty	Probe Dist.	Div.	(Ci) E	(Ci) H		Std. Unc.(±%)	
	value (±%)	FIDDE DISI.	Div.	(0) L		E	Н	
Measurement System								
Probe Calibration	5.10	N	1	1	1	5.1	5.1	
Axial Isotropy	4.70	R	1.732	1	1	2.7	2.7	
Sensor Displacement	16.50	R	1.732	1	0.145	9.5	1.4	
Boundary Effects	2.40	R	1.732	1	1	1.4	1.4	
Linearity	4.70	R	1.732	1	1	2.7	2.7	
Scaling to Peak Envelope Power	2.00	R	1.732	1	1	1.2	1.2	
System Detection Limit	1.00	R	1.732	1	1	0.6	0.6	
Readout Electronics	0.30	N	1	1	1	0.3	0.3	
Response Time	0.80	R	1.732	1	1	0.5	0.5	
Integration Time	2.60	R	1.732	1	1	1.5	1.5	
RF Ambient Conditions	3.00	R	1.732	1	1	1.7	1.7	
RF Reflections	12.00	R	1.732	1	1	6.9	6.9	
Probe Positioner	1.20	R	1.732	1	0.67	0.7	0.5	
Probe Positioning	4.70	R	1.732	1	0.67	2.7	1.8	
Extrapolation and Interpolation	1.00	R	1.732	1	1	0.6	0.6	
Test sample Related								
Test Positioning Vertical	4.70	R	1.732	1	0.67	2.7	1.8	
Test Positioning Lateral	1.00	R	1.732	1	1	0.6	0.6	
Device Holder and Phantom	2.40	R	1.732	1	1	1.4	1.4	
Power Drift	5.00	R	1.732	1	1	2.9	2.9	
Phantom and Setup Related								
Phantom Thickness	2.40	R	1.732	1	0.67	1.4	0.9	
Combined Std. Uncertainty 14.7 1						10.9		
Expanded Std. Uncertainty on Power 29.4 2						21.8		
Expanded Std. Uncertainty on Field						14.7	10.9	
Notesfor table 1. N - Nomal								
2. R - Rectangular								
3. Div Divisor used to obtain standard uncertainty								
4. Ci - is te sensitivity coefficient								

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5. Equipment Under Test

Cellular/PCS/AWS CDMA and LTE Band 2/4 Phone with Bluetooth and WLAN.

MODEL: MS840, LGMS840 and LG-MS840

5.1. List of Air Interfaces/Bands & Operating Modes

Air- Interface	Bands (MHz)	Туре	C63.19/ Tested	Simultaneous Transmissions Note: Not to be tested	Concurrent single transmission	Reduced power 20.19 (c) (1)	Voice Over Digital Transport (Data)
	800		Yes	Yes			
CDMA	1900	VO	Yes	LTE, EV-DO, WiFi and Bluetooth	Yes: EV-DO, LTE, WiFi and Bluetooth	N/A	N/A
	EV-DO	DT	N/A	N/A	Yes: * see note	Yes: **SVDO mode only	Yes
LTE	Band 2 & 4	DT	N/A	Yes EV-DO, WiFi and Bluetooth	Yes: * see note	Yes: **SVLTE mode only	Yes
WiFi	2450	DT	N/A	Yes CDMA,GSM,UMTE, LTE, EV-DO and Bluetooth	N/A	N/A	Yes
Bluetooth	2400	DT	N/A	Yes CDMA,GSM,UMTE, LTE, EV-DO and WiFi	N/A	N/A	N/A
V/D Void	VO Voice CMRS/PTSN Service Only Note(s): V/D Voice CMRS/PSTN and Data Service * HAC Rating was not base on concurrent voice and data modes, DT Digital Transport Noncurrent mode was found to represent worst case rating. For M rating ** SVDO: CDMA voice and EVDO Simultaneously transmission SVLTE: CDMA voice and LTE Simultaneously transmission						

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6. System Specifications

E-field and H-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland.

The DASY5 HAC Extension consists of the following parts:

Test Arch Phantom

The specially designed Test Arch allows high precision positioning of both the device and any of the validation dipoles.

ER3DV6 Isotropic E-Field Probe

Construction:	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Calibration:	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, k=2)
Frequency:	100 MHz to > 6 GHz; Linearity: \pm 0.2 dB (100 MHz to 3 GHz)
Directivity:	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range:	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB
Dimensions:	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm The closest part of the sensor element is 1.1 mm closer to the tip
Application:	General near-field measurements up to 6 GHz

Field component measurements

H3DV6 3-Dimensional H-Field Probe

Construction:	Three concentric loop sensors with 3.8 mm loop diameters resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Frequency:	200 MHz to 3 GHz (absolute accuracy \pm 6.0%, k=2); Output linearized
Directivity:	± 0.25 dB (spherical isotropy error)
Dynamic Range:	10 mA/m to 2 A/m at 1 GHz
E-Field Interference:	< 10% at 3 GHz (for plane wave)
Dimensions:	Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm The closest part of the sensor element is 1.9 mm closer to the tip
Application:	General magnetic near-field measurements up to 3 GHz Field component measurements Surface current measurements Measurements in air or liquids Low interaction with the measured field

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7. System Validation

The test setup was validated when first configured and verified periodically thereafter to ensure proper function. The procedure provided in this section is a validation procedure using dipole antennas for which the field levels were computed by numeric modeling.

Procedure

Place a dipole antenna meeting the requirements given in ANSI-PC63.19 2007 in the normally occupied by the WD.

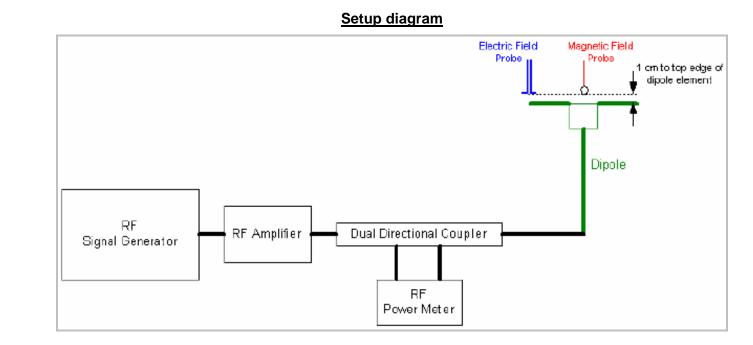
The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna

- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions; and

- The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements.

Scan the length of the dipole with both E-field and H-field probes and record the maximum values for each. Compare the readings to expected values.



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7.1. System Validation Results

			Max. mea	sured from	Average max.	E-field Target	
Calibration Dipole	f (MHz)	Input Power (mW)	above high end (V/m)	above low end (V/m)	above arm (V/m)	Values (V/m) (From SPEAG)	Deviation ¹⁾ (%)
CD835V3 SN 1175	835	100	174.3	177.3	175.80	171.0	2.81
CD1880V3 SN 1159	1730	100	153.5	159.2	156.35	149.9	4.30
CD1880V3 SN 1159	1880	100	139.1	142.7	140.90	140.3	0.43

H-field

Calibration Dipole	f (MHz)	Input Power (mW)	Measured H-field (A/m)	H-field Target Values (A/m) (From SPEAG)	Deviation ¹⁾ (%)
CD835V3 SN 1175	835	100	0.467	0.475	-1.68
CD1880V3 SN 1159	1730	100	0.461	0.495	-6.87
CD1880V3 SN 1159	1880	100	0.455	0.464	-1.94

Notes:

- Delta (Deviation) % = 100 * (Measured value minus Target value) divided by the Target value. Deltas within ±25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty.
- 2) The maximum E-field or H-field were evaluated and compared to the target values provided by SPEAG in the calibration certificate of specific dipoles.
- 3) Please refer to the attachment for detailed measurement data and plots.

8. Probe Modulation Factor (PMF)

Purpose

The HAC Standard requires measurement of the peak envelope E- and H-fields of the wireless device (WD). Para. 4.2.2.1, and C.3.1 of the standard describes the Probe Modulation Response Factor that shall be applied to convert the probe reading to Peak Envelope Field.

Definitions

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in the Standard (Chapter C.3.1).

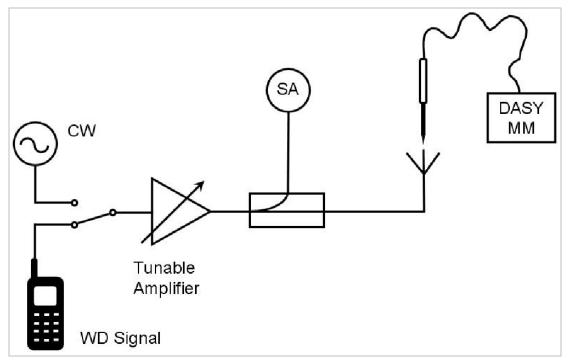
Evaluation Procedure for Unknown PMF (DASY4 Application note, Section 28.8)

The proposed measurement setup corresponds to the procedure as required in the Standard, Chapter C.3.1.

- 1. Install a calibration dipole for the appropriate frequency band under the Test Arch Phantom and select the proper phantom section according to the probe type installed (E- or H-field). Move the probe to the field reference point. (Do not move the probe between the subsequent CW and modulated measurements.)
- 2. Install the field probe in the setup.
- 3. The modulated signal to the dipole must be monitored to record peak amplitude and compared to a CW signal with the same peak envelope level (e.g., with a directional coupler and a spectrum analyzer in zero span mode set to the operating frequency). To determine the peak envelope level of the modulated signal properly, the settings of a spectrum analyzer shall be as follows:
 - Resolution bandwidth >= emission bandwidth (4 MHz for UMTS bands, 300 kHz)
 - Video bandwidth >= 20 kHz
 - Span: zero
 - Center Frequency: nominal center frequency of channel
 - Detection: RMS detection with averaging turned on
 - Trigger: Video or IF trigger, adjusted to give a stable display of the transmission
 - Sweep rate: Sufficiently rapid to permit the transmit pulse to be resolved accurately. The sweep shall be long enough to show a complete transmission. The sweep time may be set to allow a full transmission cycle, displaying the on and off time.
- 4. Define a DASY4 document and set the procedure properties (frequency, modulation frequency and crest factor) according to the measured signal. Define a multimeter job for the field reading.
- 5. Define a second procedure for the evaluation of the CW signal (frequency set as above, modulation frequency = 0, crest factor = 1) and a multimeter job.

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PMF Measurement Setup Diagram



The HAC measurement procedure is as follows:

- a) Modulated signals (WD and 80% AM) measurement:
 - 1) Connect the modulated signal using the appropriate frequency via the cable to the dipole.
 - 2) The signal to the dipole must be monitored to record peak amplitude with a directional coupler and a spectrum analyzer.
 - 3) Run the multimeter job in the procedure with the corresponding modulation setting in continuous mode.
 - 4) Read the envelope peak on the monitor in order to adjust the CW signal later to the same level.
- b) CW signal measurement:
 - 1) Change the signal to CW at the same center frequency, without touching or moving the dipole and probe in the setup.
 - 2) Adjust the CW signal amplitude to the same peak level on the spectrum analyzer (keep the same bandwidth and attenuation for CW and modulated signals).
 - 3) Run the multimeter job in the CW procedure in continuous mode.
 - 4) Read the multimeter total field display and note it together with modulation type and frequency.
 - 5) Calculate the Probe Modulation Factor as the ratio between the CW multimeter field reading and

the reading for the applicable modulation. I.e., $PMF = \frac{E_{cw}}{E_{mod}}$ and similar for H.

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8.1. **PMF Measurement Results**

CDMA2000

Probe	Frequency (MHz)	Type of signal	E-field V/m	PMF	
	835	CDMA (RC3/SO55)	64.6	0.95	
	000	CW	61.4	0.95	
E-Field Probe	1730	CDMA (RC3/SO55)	45.2	0.96	
	1750	CW	43.2	0.90	
	1880	CDMA (RC3/SO55)	44.7	0.95	
		CW	42.6	0.95	
Probe	Frequency (MHz)	Type of signal	H-field A/m	PMF	
	835	CDMA (RC3/SO55)	0.260	0.96	
	000	CW	0.249	0.90	
H-Field Probe	1730	CDMA (RC3/SO55)	0.196	0.96	
	1730	CW	0.188	0.90	
	1880	CDMA (RC3/SO55)	0.190	0.98	
	1000	CW	0.187	0.98	

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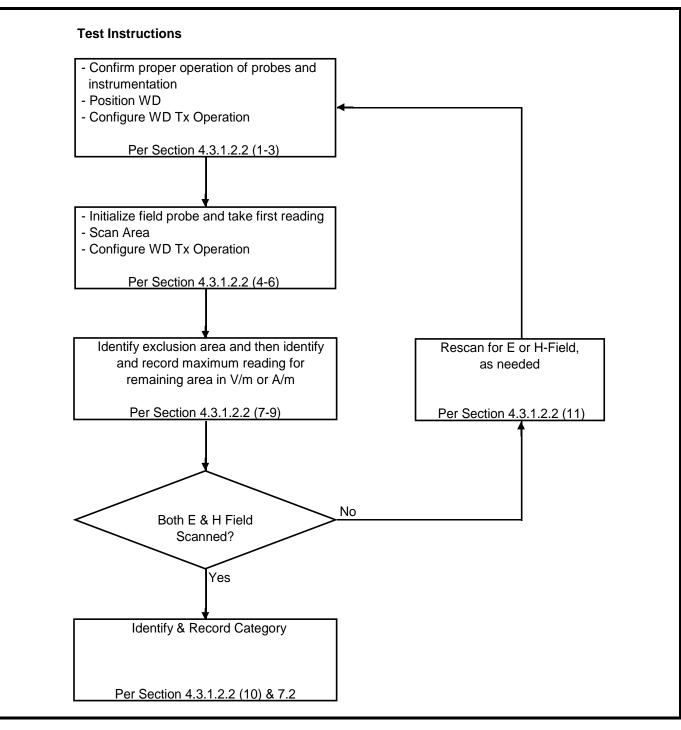
9. HAC RF Emissions Test Procedure

The following are step-by-step test procedures.

- 1. Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2. Position the WD in its intended test position.
- 3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters, (e.g. test mode) as intended for the test.
- 4. The center sub-grid shall be centered on the center of the WD output (acoustic or T-coil output), as appropriate. Locate the field probe at the initial test position in the 5 x 5 cm grid, which is contained in the measurement plane, see illustrated in Figure 5.
- 5. Record the reading.
- 6. Scan the entire 5 x 5 cm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the peak reading.
- 7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum strength readings. Thus the 6 areas to be used to determine the WD's peak emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E- and H-field measurements for the WD output being measured. State another way, the center sub-grid and 3 other must be common to both the E- and H-field measurements.
- 8. Identify the highest field reading within the non-excluded sub-grids identified in step 7.
- 9. Convert the highest field reading within identified in step 8 to peak V/m or A/m, as appropriate.
- 10. Repeat steps 1-10 for both the E- and H-field measurements.
- 11. Compare this reading to the categories in ANSI-PC63.19 and record the resulting category. The lowest category number listed in ANSI-PC63.19 obtained in step 10 for either E or H field determines the M category for the audio coupling mode assessment. Record the WD category rating.

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Test flowchart Per ANSI-PC63.19 2007



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10. RF Emissions Measurement Criteria

Telephone near-field Categories in linear units

			Telephone RF Parameters			
		< 960) MHz	z > 960 MHz		
		E-Field	H-Field	E-Field	H-Field	
Category	AWF	Emissions (V/m)	Emissions (A/m)	Emissions (V/m)	Emissions (A/m)	
M3	0	199.5 to 354.8	0.60 to 1.07	63.1 to 112.2	0.19 to 0.34	
1015	-5	149.6 to 266.1	0.45 to 0.80	47.3 to 84.1	0.14 to 0.25	
M4	0	< 199.5	< 0.60	< 63.1	< 0.19	
1014	-5	< 149.6	< 0.45	< 47.3	< 0.14	

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11. HAC (RF Emissions) Test Results

11.1. E-Field Emissions

				Peak	
Operating Mode	Ch. No.	f (MHz)	PMF	E-Field (V/m)	M-Rating
CDMA Cell	1013	824.70		50.740	M4
1xRTT	384	836.52	0.95	52.652	M4
(RC3, SO55)	777	848.31		54.262	M4
CDMA AWS	25	1711.25		26.326	M4
1xRTT	450	1732.50	0.96	25.639	M4
(RC3, SO55)	875	1753.75		27.675	M4
CDMAPCS	25	1851.25		28.918	M4
1xRTT	600	1880.00	0.95	30.153	M4
(RC3, SO55)	1175	1908.75		33.834	M4

11.2. H- Field Emissions

				Peak	
Operating Mode	Ch. No.	f (MHz)	PMF	H-Field (A/m)	M-Rating
CDMA Cell	1013	824.70		0.075	M4
1xRTT	384	836.52	0.96	0.079	M4
(RC3, SO55)	777	848.31		0.078	M4
CDMA AWS	25	1711.25		0.075	M4
1xRTT	450	1732.50	0.96	0.069	M4
(RC3, SO55)	875	1753.75		0.077	M4
CDMA PCS	25	1851.25		0.080	M4
1xRTT	600	1880.00	0.98	0.089	M4
(RC3, SO55)	1175	1908.75		0.088	M4

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12. Worst-case Test Plots

E-field worst-cast test plot for Part 22

Date: 8/29/2011

Test Laboratory: UL CCS SAR Lab C

CDMA2000_Cell Band

Communication System: CDMA2000; Frequency: 848.31 MHz;Duty Cycle: 1:1 Phantom section: RF Section DASY4 Configuration:

- Probe: ER3DV6 SN2509; ConvF(1, 1, 1); Calibrated: 4/8/2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1257; Calibrated: 5/3/2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BB
- Measurement SW: DASY52, Version 52.6 (2);SEMCAD X Version 14.4.5 (3634)

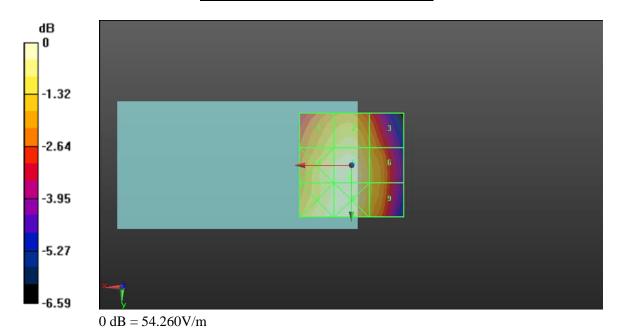
E-Field, 1x RTT (RC3, SO55)/H ch/Hearing Aid Compatibility Test (101x101x1): Measurement

grid: dx=5mm, dy=5mm Maximum value of peak Total field = 54.262 V/m Probe Modulation Factor = 0.950 Device Reference Point: 0, 0, -6.3 mm Reference Value = 75.390 V/m; Power Drift = 0.10 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
48.897 M4	50.715 M4	45.748 M4
Grid 4	Grid 5	Grid 6
52.543 M4	54.262 M4	48.344 M4
Grid 7	Grid 8	Grid 9
52.816 M4	54.005 M4	48.204 M4



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E-field worst-cast test plot for AWS Band

Date: 8/29/2011

Test Laboratory: UL CCS SAR Lab C

CDMA2000_AWS Band

Communication System: CDMA2000; Frequency: 1753.75 MHz;Duty Cycle: 1:1 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2509; ConvF(1, 1, 1); Calibrated: 4/8/2011

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn1257; Calibrated: 5/3/2011

- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BB

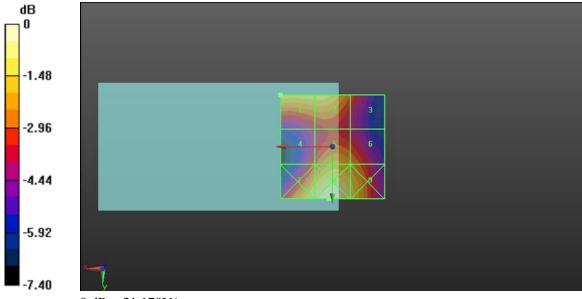
- Measurement SW: DASY52, Version 52.6 (2);SEMCAD X Version 14.4.5 (3634)

E-Field, 1x RTT (RC3, SO55)/H ch/Hearing Aid Compatibility Test (101x101x1): Measurement

grid: dx=5mm, dy=5mm Maximum value of peak Total field = 27.675 V/m Probe Modulation Factor = 0.960 Device Reference Point: 0, 0, -6.3 mm Reference Value = 30.382 V/m; Power Drift = 0.01 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m				
Grid 1	Grid 2	Grid 3		
27.675 M4	27.428 M4	22.335 M4		
Grid 4	Grid 5	Grid 6		
21.878 M4	25.471 M4	24.165 M4		
Grid 7	Grid 8	Grid 9		
29.621 M4	31.172 M4	27.508 M4		



 $0 \, dB = 31.170 \, V/m$

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E-field worst-cast test plot for Part 24

Date: 8/29/2011

Test Laboratory: UL CCS SAR Lab C

CDMA2000_PCS Band

Communication System: CDMA2000; Frequency: 1908.75 MHz;Duty Cycle: 1:1 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2509; ConvF(1, 1, 1); Calibrated: 4/8/2011

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn1257; Calibrated: 5/3/2011

- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BB

- Measurement SW: DASY52, Version 52.6 (2);SEMCAD X Version 14.4.5 (3634)

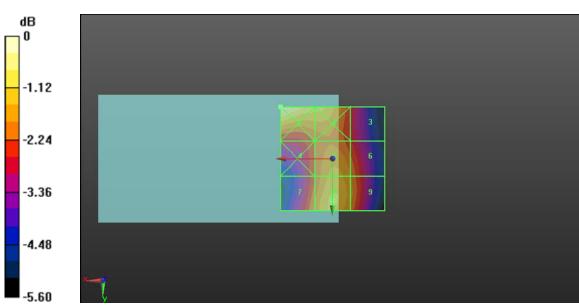
E-Field, 1x RTT (RC3, SO55)/H ch/Hearing Aid Compatibility Test (101x101x1): Measurement

grid: dx=5mm, dy=5mm Maximum value of peak Total field = 33.834 V/m Probe Modulation Factor = 0.950 Device Reference Point: 0, 0, -6.3 mm Reference Value = 42.910 V/m; Power Drift = -0.21 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m				
Grid 1	Grid 2	Grid 3		
38.089 M4	34.308 M4	28.476 M4		
Grid 4	Grid 5	Grid 6		
29.670 M4	32.644 M4	30.817 M4		
Grid 7	Grid 8	Grid 9		

31.282 M4 33.834 M4 31.316 M4



 $0 \, dB = 38.090 \, V/m$

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H-field worst-cast test plot for Part 22

Date: 8/29/2011

Test Laboratory: UL CCS SAR Lab C

CDMA2000_Cell Band

Communication System: CDMA2000; Frequency: 836.52 MHz;Duty Cycle: 1:1 Phantom section: RF Section

DASY4 Configuration:

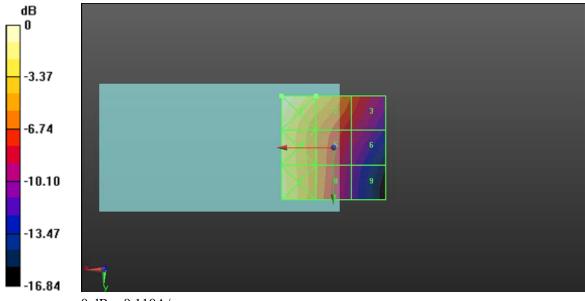
- Probe: H3DV6 SN6324; ; Calibrated: 4/11/2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1257; Calibrated: 5/3/2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BB
- Measurement SW: DASY52, Version 52.6 (2);SEMCAD X Version 14.4.5 (3634)

H-Field, 1x RTT (RC3, SO55)/M ch/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.079 A/m Probe Modulation Factor = 0.960 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.049 A/m; Power Drift = -0.10 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m				
Grid 1	Grid 2	Grid 3		
0.111 M4	0.079 M4	0.051 M4		
Grid 4	Grid 5	Grid 6		
0.091 M4	0.060 M4	0.040 M4		
Grid 7	Grid 8	Grid 9		
0.090 M4	0.059 M4	0.032 M4		



 $0 \, dB = 0.110 \, A/m$

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H-field worst-cast test plot for AWS Band

Date: 8/29/2011

Test Laboratory: UL CCS SAR Lab C

CDMA2000_AWS Band

Communication System: CDMA2000; Frequency: 1753.75 MHz;Duty Cycle: 1:1 Phantom section: RF Section

DASY4 Configuration:

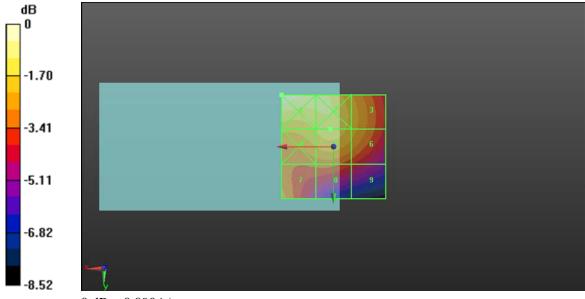
- Probe: H3DV6 SN6324; ; Calibrated: 4/11/2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1257; Calibrated: 5/3/2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BB
- Measurement SW: DASY52, Version 52.6 (2);SEMCAD X Version 14.4.5 (3634)

H-Field, 1x RTT (RC3, SO55)/H ch/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.077 A/m Probe Modulation Factor = 0.960 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.086 A/m; Power Drift = -0.10 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m				
Grid 1	Grid 2	Grid 3		
0.091 M4	0.082 M4	0.073 M4		
Grid 4	Grid 5	Grid 6		
0.075 M4	0.077 M4	0.072 M4		
Grid 7	Grid 8	Grid 9		
0.068 M4	0.063 M4	0.058 M4		



 $0 \, dB = 0.090 \, A/m$

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H-field worst-cast test plot for Part 24

Date: 8/29/2011

Test Laboratory: UL CCS SAR Lab C

CDMA2000_PCS Band

Communication System: CDMA2000; Frequency: 1880 MHz;Duty Cycle: 1:1 Phantom section: RF Section

DASY4 Configuration:

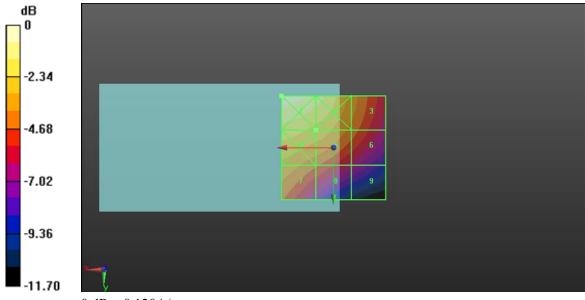
- Probe: H3DV6 SN6324; ; Calibrated: 4/11/2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1257; Calibrated: 5/3/2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BB
- Measurement SW: DASY52, Version 52.6 (2);SEMCAD X Version 14.4.5 (3634)

H-Field, 1x RTT (RC3, SO55)/M ch/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.089 A/m Probe Modulation Factor = 0.980 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.082 A/m; Power Drift = -0.02 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m				
Grid 1	Grid 2	Grid 3		
0.118 M4	0.105 M4	0.081 M4		
Grid 4	Grid 5	Grid 6		
0.097 M4	0.089 M4	0.074 M4		
Grid 7	Grid 8	Grid 9		
0.082 M4	0.071 M4	0.056 M4		



 $0 \, dB = 0.120 \, A/m$

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13. Appendixes

Refer to separated files for the following appendixes

- **13.1.** Appendix A: System Validation Plots
- 13.2. Appendix B: E-field emissions test plots
- **13.3.** Appendix C: H-field emissions test plots
- 13.4. Appendix D: Calibration Certificate E-Field Probe ER3DV6 SN 2509
- 13.5. Appendix E: Calibration Certificate H-Field Probe H3DV6 SN 6324
- 13.6. Appendix F: Calibration Certificate for Dipole CD835V3 SN 1175
- 13.7. Appendix G: Calibration Certificate for Dipole CD1880V3 SN 1159